

600 V / 4 A, High-Side Automotive Gate Driver IC

FAD7171MX

Description

The FAD7171MX is a monolithic high–side gate drive IC that can drive high–speed MOSFETs and IGBTs that operate up to +600 V. It has a buffered output stage with all NMOS transistors designed for high pulse current driving capability and minimum cross–conduction. **onsemi**'s high–voltage process and common–mode noise–canceling techniques provide stable operation of the high–side driver under high dv/dt noise circumstances. An advanced level–shift circuit offers $^{\circ}C$

MARKING DIAGRAM

FAD7171MX SOIC8 (Pb-Free / Halogen Free) 2500 / Tape & Reel

Applications

- Common Rail Injection Systems
- DC-DC Converter
- Motor Drive (Electric Power Steering, Fans)

Related Product Resources

- FAN7171 Product Folder
- FAD7171 Product Folder
- <u>AND9674</u> Design and Application Guide of Bootstrap Circuit for High–Voltage Gate–Drive IC
- <u>AN-8102</u> Recommendations to Avoid Short Pulse Width Issues in HVIC Gate Driver Applications
- AN-9052 Design Guide for Selection of Bootstrap Components

PIN DESCRIPTION

Pin No.	Symbol	Description	
1	V _{DD}	Supply Voltage	
2	IN	Logic Input for High-Side Gate Driver Output	
3	NC	No Connection	
4	GND	Ground	
5	NC	No Connection	
6	VS	High-Voltage Floating Supply Return	
7	НО	High-Side Driver Output	
8	VB	High–Side Floating Supply	

ABSOLUTE MAXIMUM RATINGS

Symbol	Characteristics	Min	Max	Unit
VS	High–Side Floating Offset Voltage	V _B – 25	V _B + 0.3	V
VB	High–Side Floating Supply Voltage	-0.3	625.0	V
V _{HO}	High-Side Floating Output Voltage	V _S – 0.3	V _B + 0.3	V
V _{DD}	Low-Side and Logic Supply Voltage	-0.3	25	V
V _{IN}	Logic Input Voltage	-0.3	V _{DD} + 0.3	V
dV _S /dt	Allowable Offset Voltage Slew Rate	_	±50	V/ns
PD	Power Dissipation (Notes 2, 3, 4)	-	0.625	W
θ_{JA}	Thermal Resistance	-	200	°C/W
TJ	Junction Temperature	-		

ELECTRICAL CHARACTERISTICS (V_{BIAS} (V_{DD}, V_{BS}) = 15 V, $-40^{\circ}C \le T_A \le 125^{\circ}C$, unless otherwise specified. The V_{IN} and I_{IN} parameters are referenced to GND. The V_O and I_O parameters are relative to V_S and are applicable to the respective output HO)

Symbol

TYPICAL PERFORMANCE CHARACTERISTICS



Figure 9. Operating V_{BS} Supply Current vs. Temperature

Temperature

TYPICAL PERFORMANCE CHARACTERISTICS (continued)



SWITCHING TIME DEFINITIONS



Figure 22. Switching Time Test Circuit (Referenced 8–SOIC)



Figure 23. Switching Time Waveform Definitions



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SEATING PLANE



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